

COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

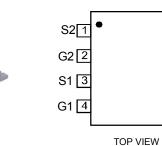
Device	V _{(BR)DSS}	R _{DS(on)} max	l _D T _A = +25°C
Q2	$24m\Omega @ V_{GS} = 10V$		9.0A
QZ	Q2 40V	32mΩ @ V _{GS} = 4.5V	7.8A
Q1	401/	45mΩ @ V _{GS} = -10V	-6.5A
QI	-40V	55mΩ @ V _{GS} = -4.5V	-5.9A

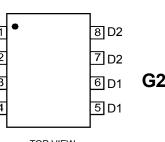
Description

This new generation MOSFET has been designed to minimize the onstate resistance (R_{DS(on)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- **DC-DC Converters**
- Power Management Functions
- Backlighting



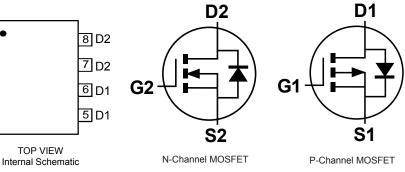


Features and Benefits

- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 (e3)
- Weight: 0.074 grams (approximate)



Ordering Information (Note 4 & 5)

Top View

Part Number	Compliance	Case	Packaging
DMC4029SSD-13	Standard	SO-8	2,500/Tape & Reel
DMC4029SSDQ-13	Automotive	SO-8	2,500/Tape & Reel

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

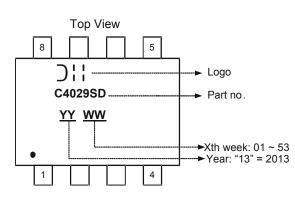
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. Automotive products are AEC-Q101 gualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www.diodes.com/quality/product_grade_definitions/.

5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

Notes:





Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value_Q2	Value_Q1	Units		
Drain-Source Voltage	V _{DSS}	40	-40	V		
Gate-Source Voltage	V _{GSS}	±20	±20	V		
	Steady State	T _A = +25°C T _A = +70°C	ID	7.0 5.6	-5.1 -4.1	А
Continuous Drain Current (Note 7) V _{GS} = 10\	t<10s	T _A = +25°C T _A = +70°C	ID	9.0 7.2	-6.5 -5.2	А
Maximum Body Diode Forward Current (Note 7)	ls	2.5	-2.5	А		
Pulsed Drain Current (10µs pulse, duty cycle = 19	I _{DM}	70	-40	А		

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Dawar Dissinction (Nate 6)	T _A = +25°C	P	1.3	W
Total Power Dissipation (Note 6)	T _A = +70°C	PD	0.8	
Thermal Desistance, lunction to Ambient (Note C)	Steady state	Р	98	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	59	
Total Power Dissipation (Note 7)	T _A = +25°C	Р	1.8	W
Total Power Dissipation (Note 7)	T _A = +70°C	PD	1.1	
Thermal Resistance, Junction to Ambient (Note 7)	Steady state	Р	71	°C/W
Thermal Resistance, Junction to Ambient (Note 7)	t<10s	$R_{\theta JA}$	43	
Thermal Resistance, Junction to Case (Note 7)		R _{0JC}	11.8	
Operating and Storage Temperature Range		T _{J.} T _{STG}	-55 to +150	°C

Electrical Characteristics N-Channel Q2 (@T_A = +25°C, unless otherwise specified.)

P						-
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						-
Drain-Source Breakdown Voltage	BV _{DSS}	40		_	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current	I _{DSS}			1	μA	V_{DS} = 40V, V_{GS} = 0V
Gate-Source Leakage	I _{GSS}		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1.0	_	3.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance			15	24	mΩ	V _{GS} = 10V, I _D = 6A
	R _{DS(ON)}	_	20	32	11152	V_{GS} = 4.5V, I_{D} = 5A
Diode Forward Voltage	V _{SD}	_	0.7	1.0	V	V _{GS} = 0V, I _S = 1.0A
DYNAMIC CHARACTERISTICS (Note 9)				•		
Input Capacitance	Ciss		1060		pF	V _{DS} = 20V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	Coss	_	84	_		
Reverse Transfer Capacitance	C _{rss}	_	58			
Gate Resistance	R _G		1.6	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg		8.8	_		
Total Gate Charge (V _{GS} = 10V)	Qg		19.1	_	nC	$V_{DS} = 20V$. ID = 8A
Gate-Source Charge	Qgs		3.0	_	nc	$v_{DS} = 20v, I_D = 6A$
Gate-Drain Charge	Q _{gd}		2.5	_		
Turn-On Delay Time	t _{D(on)}		5.3	_		
Turn-On Rise Time	tr	_	7.1	_		$V_{DD} = 25V, R_{L} = 2.5\Omega$
Turn-Off Delay Time	t _{D(off)}	_	15.1	_	nS	V _{GS} = 10V, R _G = 3Ω
Turn-Off Fall Time	tf		4.8	_		
Body Diode Reverse Recovery Time	t _{rr}	_	10.5	_	nS	I _F = 8A, di/dt = 100A/µs
Body Diode Reverse Recovery Charge	Qrr		4.15	_	nC	I _F = 8A, di/dt = 100A/µs



Electrical Characteristics P-Channel Q1 (@T_A = +25°C, unless otherwise specified.)

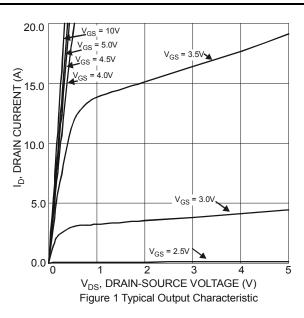
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	-40	—	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	IDSS	_	—	-1	μA	$V_{DS} = -40V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	—	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	-1.0	—	-3.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance	Descourse	_	33	45	mΩ	V _{GS} = -10V, I _D = -5A
Static Drain-Source On-Resistance	R _{DS(ON)}	_	40	55	1115.2	V_{GS} = -4.5V, I_{D} = -4A
Diode Forward Voltage	V _{SD}	_	-0.7	-1.0	V	V _{GS} = 0V, I _S = -1.0A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	_	1154	_	pF	V _{DS} = -20V, V _{GS} = 0V f = 1.0MHz
Output Capacitance	C _{oss}	_	84	_		
Reverse Transfer Capacitance	C _{rss}	_	66	_		
Gate Resistance	R _G	_	12.6	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = -4.5V)	Qg	_	10.6	_		
Total Gate Charge (V _{GS} = -10V)	Qg	_	21.5	_	nC	VDS = -20V. ID = -4.9A
Gate-Source Charge	Q _{gs}	_	2.2	_	nc	VDS = -20V, ID = -4.9A
Gate-Drain Charge	Q _{gd}	_	3.3	—		
Turn-On Delay Time	t _{D(on)}	_	8.7	_		
Turn-On Rise Time	tr		19.6	_	nS	VDS = -20V, ID = -3.9A
Turn-Off Delay Time	t _{D(off)}		34.9	_	113	V_{GS} = -4.5V, R_{G} = 1 Ω
Turn-Off Fall Time	t _f		25.5	_		
Body Diode Reverse Recovery Time	t _{rr}		9.61	_	nS	I _S = -3.9A, dI/dt = 100A/µs
Body Diode Reverse Recovery Charge	Qrr	_	3.3	_	nC	I _S = -3.9A, dl/dt = 100A/µs

Notes: 6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

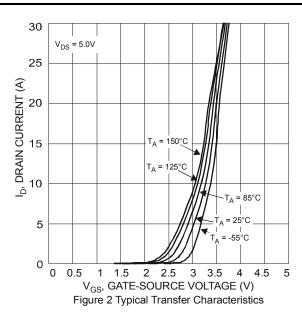
7. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

8. Short duration pulse test used to minimize self-heating effect.

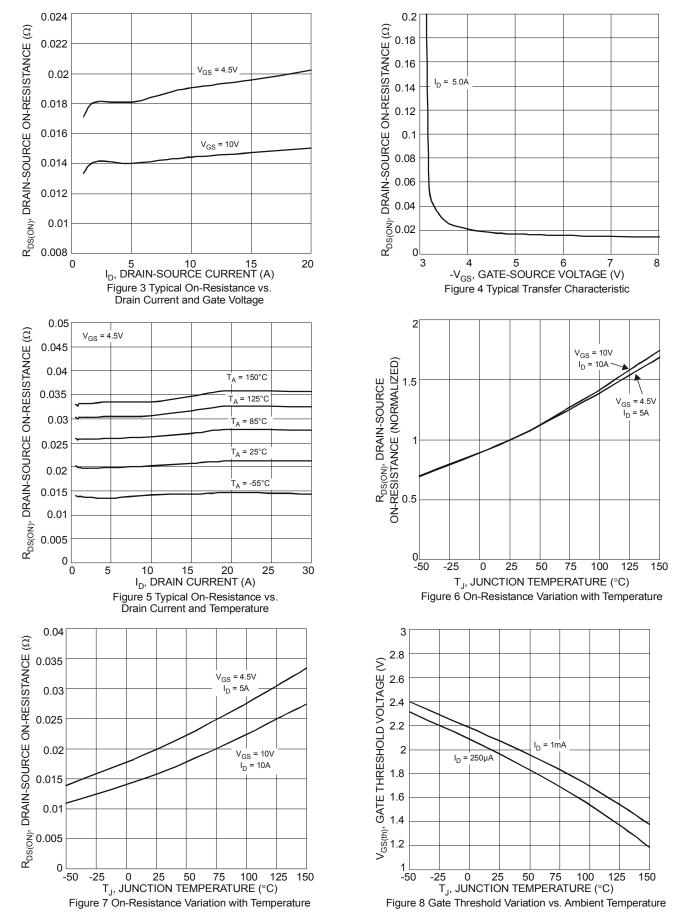
9. Guaranteed by design. Not subject to product testing.



N-Channel Q2

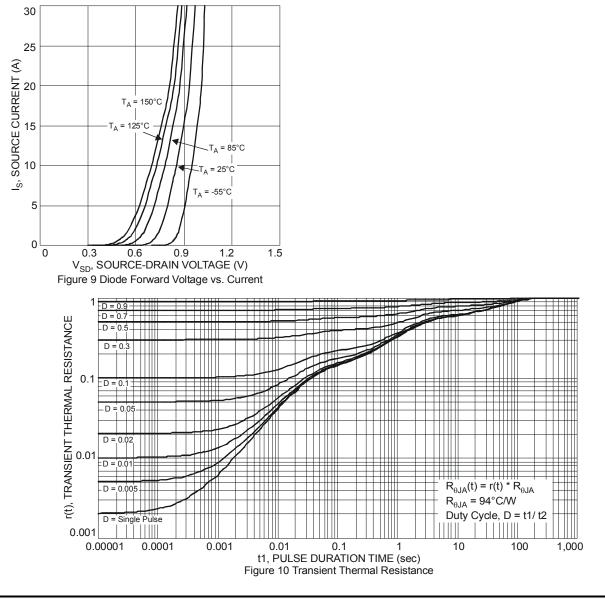




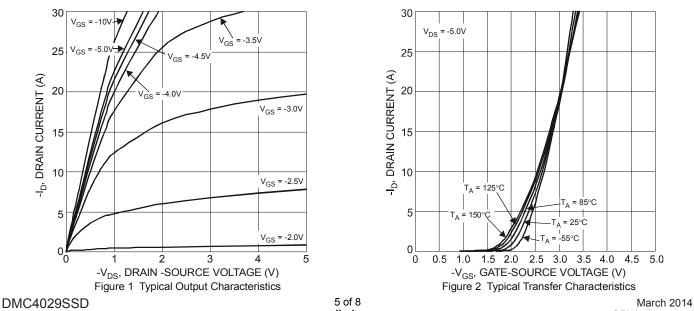


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P-Channel Q1

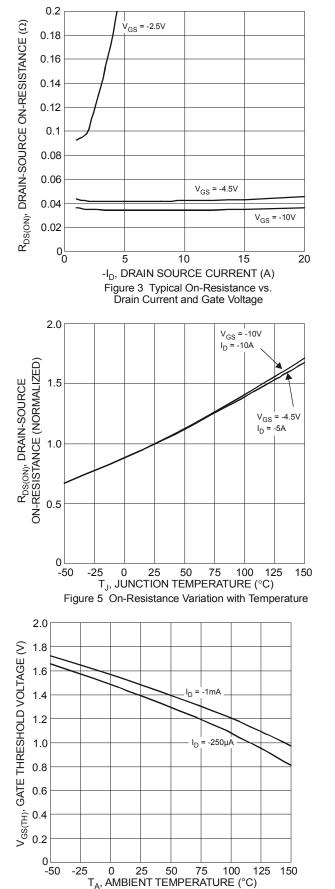


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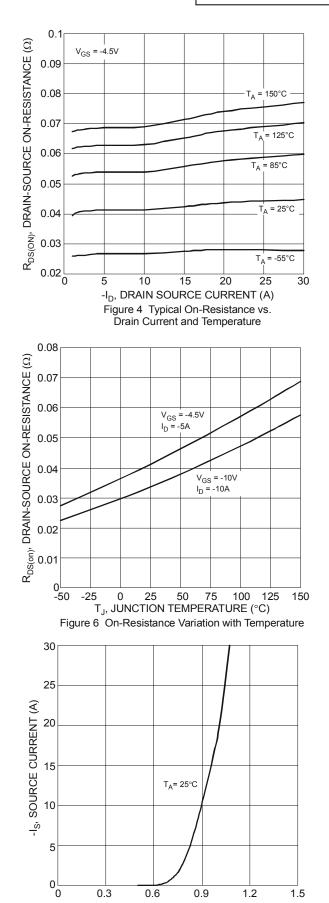
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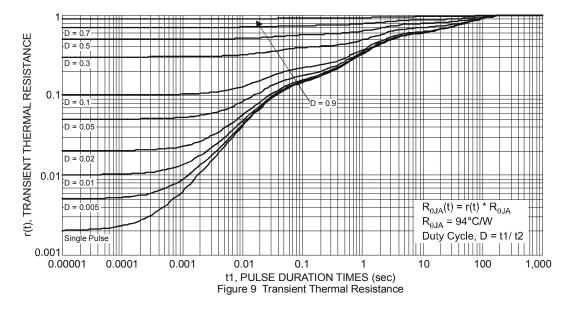






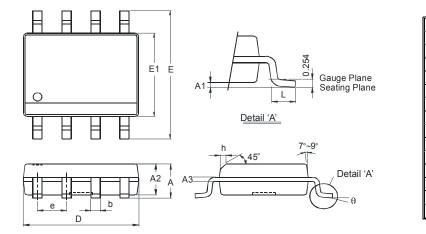
-V_{SD}, SOURCE-DRAIN VOLTAGE (V) Figure 8 Diode Forward Voltage vs. Current





Package Outline Dimensions

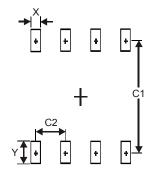
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SO-8						
Dim	Min	Max				
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3	0.5				
D	4.85	4.95				
Е	5.90	6.10				
E1	3.85	3.95				
е	1.27 Typ					
h	- 0.35					
L	0.62	0.82				
θ	0° 8°					
All Di	mensions	in mm				

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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